Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/661,638	HIRAIWA ET AL.	
Examiner	Art Unit	
Lois Zheng	1742	

SEARCHED					
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventorship search	8/13/2007	LLZ		
Updated EAST search	8/13/2007	LLZ		
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